

**UNITED STATES PATENT AND TRADEMARK OFFICE**

Examiner: To Be Assigned

Art Unit: To Be Assigned

Re: Application of:

**Werner KNEBEL et al.**

Serial No.:

To Be Assigned

Filed:

Herewith as national phase of International  
Application No. PCT/DE2003/003163, filed 23  
September 2003

For:

**SCANNING MICROSCOPE COMPRISING A  
CONFOCAL SLIT SCANNER FOR  
REPRODUCING AN OBJECT**

Customer No:

23280

**INFORMATION DISCLOSURE STATEMENT**Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

June 2, 2005

S i r:

In accordance with the provisions of 37 C.F.R. § 1.97, Applicant hereby makes of record the documents listed on the accompanying PTO-1449 Form (1 page) for consideration by the Examiner in connection with the examination of the above-identified patent application. While the references are being submitted herewith, some or all of the references may not constitute prior art under the U.S. patent laws.

Some of the documents listed on the accompanying PTO-1449 Form were cited in the International Search Report in the above-referenced International Application. A copy of that International Search Report is submitted herewith.

10/537335

JC2012 d PCT/PTO 02 JUN 2005

5033.1012

This Information Disclosure Statement is filed under 37 C.F.R. §1.97 (b), before the mailing date of a First Office Action, therefore no fee is believed due. In the event any additional fee is due in connection with this response or if any fee has been overpaid, the deficiency or overpayment should be charged to our Deposit Account No. 50-0552.

It is respectfully requested that the references cited in the accompanying PTO-1449 form be considered and made of record. It is respectfully submitted that the pending claims are patentable over all of the references made of record at this time.

Respectfully submitted,

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FORM PTO-1449  
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOKER  
5033.101210/537335  
APPLICATION NO.

To be assigned

## LIST OF PRIOR ART CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT

Werner KNEBEL et al.

FILING DATE

Herewith

GROUP

To be assigned

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
	A01	5,192,980	Mar. 9, 1993	Dixon et al.	356	326	
	A02	6,809,815	Oct. 26, 2004	Knebel	356	308	
	A03						
	A04						
	A05						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION	
							YES	NO
	A06	WO 95/07447	Mar. 16, 1995	WO-WIPO			See Abstract	
	A07	EP 1 178 345	Feb. 6, 2002	EP-Europe			Corresponds to US 6,809,815	
	A08	DE 43 30 347	Mar. 16, 1995	DE-Germany			Discussed in specification; see Abstract of corresponding WO 95/07447	
	A09	DE 199 02 625	Sep. 30, 1999	DE-Germany			Discussed in specification; see Abstract	
	A10	DE 199 06 757	Dec. 2, 1999	DE-Germany			Discussed in specification; see Abstract	
	A11							
	A12							
	A13							

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	A14	International Search Report for International Application No. PCT/DE2003/003163 (3 pages)
	A15	Andrew R. ROUSE et al.: "Multispectral imaging with a confocal microendoscope", XP-000981049, Optics Letters, Vol. 25, No. 23, Dec. 1, 2000, pp. 1708-1710
	A16	D.H. BURNS et al.: "Scanning Slit Aperture Confocal Microscopy for Three-Dimensional Imaging", XP000255795, Center for Bioengineering, University of Washington, Seattle, Washington, SCANNING Vol. 12, 1990, pp. 156-160

EXAMINER

DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.